

## Notice of References Cited

Application/Control No.

09/824,898

Examiner

Tse Chen

Applicant(s)/Patent Under Reexamination KUSHNICK, ERIC B.

Art Unit
2116

Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,194,928	02-2001	Heyne, Patrick	327/152
	В	US-5,471,165	11-1995	Liedberg, Nils P. A.	327/250
	O	US-6,265,924	07-2001	Desai, Chintan	327/276
	D	US-6,388,485	05-2002	Kim, Kyu-hyoun	327/161
	Е	US-5,604,775	02-1997	Saitoh et al.	375/376
	F	US-6,259,330	07-2001	Arai, Kouji	331/57
	G	US-6,100,735	08-2000	Lu, Crist Y.	327/158
	Н	US-5,670,904	09-1997	Moloney et al.	327/277
	1	US-			
	J	US-			
	К	US-			
	Ŀ	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
	0					
	P					
	Ø					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U						
	V						
	w						
	×						

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

